

AON7804

30V Dual N-Channel MOSFET

General Description

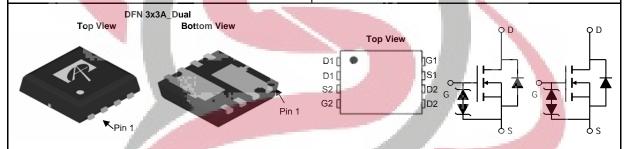
The AON7804 is designed to provide a high efficiency synchronous buck power stage with optimal layout and board space utilization. It includes two low $R_{DS\,(ON)}$ MOSFETs in a dual DFN3x3 package. The AON7804 is well suited for use in compact DC/DC converter applications.

Product Summary

 $\begin{array}{ll} V_{DS} & 30V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 22A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 21 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 26 m\Omega \end{array}$

100% UIS Tested 100% R_g Tested ESD protected





Absolute Maximum	Ratings T _A =25°C unle	ess otherwise noted			
Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V_{DS}	30	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain $T_c=25^{\circ}C$ Current $T_c=100^{\circ}C$		l _D	22 14	A	
Pulsed Drain Current C		I _{DM}	48	10.4	
Continuous Drain Current	T _A =25°C T _A =70°C	I _{DSM}	9 7	A	
Avalanche Current ^C		I _{AS} , I _{AR}	19	A	
Avalanche energy L=0.1mH C		E _{AS} , E _{AR}	18	mJ	
	T _C =25°C	P _D	17	W	
Power Dissipation ^B	T _C =100°C	r D	7	VV	
	T _A =25°C	D	3.1	W	
Power Dissipation ^A	T _A =70°C	P _{DSM}	2	VV	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics									
Parameter	Symbol	Тур	Max	Units					
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{ heta JA}$	30	40	°C/W				
Maximum Junction-to-Ambient AD	Steady-State	I \ _θ JA	60	75	°C/W				
Maximum Junction-to-Case Steady-		$R_{\theta JC}$	6.2	7.5	°C/W				



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter Conditions		Min	Тур	Max	Units				
STATIC PARAMETERS										
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V			1	μА				
	Zero Gate Voltage Brain Garrent	T _J =55°C			5	μιν				
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V			10	μΑ				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	1.2	1.8	2.4	V				
$I_{D(ON)}$	On state drain current	state drain current V _{GS} =10V, V _{DS} =5V		1		Α				
R _{DS(ON)}		V _{GS} =10V, I _D =8A	100	17	21	mΩ				
	Static Drain-Source On-Resistance	T _J =125°C	THE PERSON NAMED IN	23						
		V _{GS} =4.5V, I _D =7A	1	21	26	mΩ				
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =9A	400	30		S				
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V	7	0.75	1	V				
I _S	Maximum Body-Diode Continuous Current				15	Α				
DYNAMIC PARAMETERS										
C _{iss}	Input Capacitance		600	740	888	pF				
Coss	Output Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz	7 7	110	145	pF				
C _{rss}	Reverse Transfer Capacitance		50	82	115	pF				
R_g	Gate resistance	stance V _{GS} =0V, V _{DS} =0V, f=1MHz		1.1	1.7	Ω				
SWITCHII	NG PARAMETERS			10.00						
Q _g (10V)	Total Gate Charge		12	15	18	nC				
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =8A	6	7.5	9	nC				
Q_{gs}	Gate Source Charge	V _{GS} -10V, V _{DS} -13V, I _D -0A		2.5		nC				
Q_{gd}	Gate Drain Charge			3	97	nC				
$t_{D(on)}$	Turn-On DelayTime			5		ns				
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =1.7 Ω ,		3.5		ns				
$t_{D(off)}$	Turn-Off DelayTime	R_{GEN} =3 Ω		19		ns				
t _f	Turn-Off Fall Time			3.5	15.6	ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F = <mark>8A, dI</mark> /dt=500A/μs	6	8	10	ns				
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =8A, dI/dt=500A/μs	14	18	22	nC				
A The value of P is measured with the device mounted on tip ² EP 4 heard with 207 Copper in a still air environment with T =25°C. The										

A. The value of R_{0JA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The Power dissipation P_{DSM} is based on R_{0JA} t \leq 10s value and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

- D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to case $R_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150°C. The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C.

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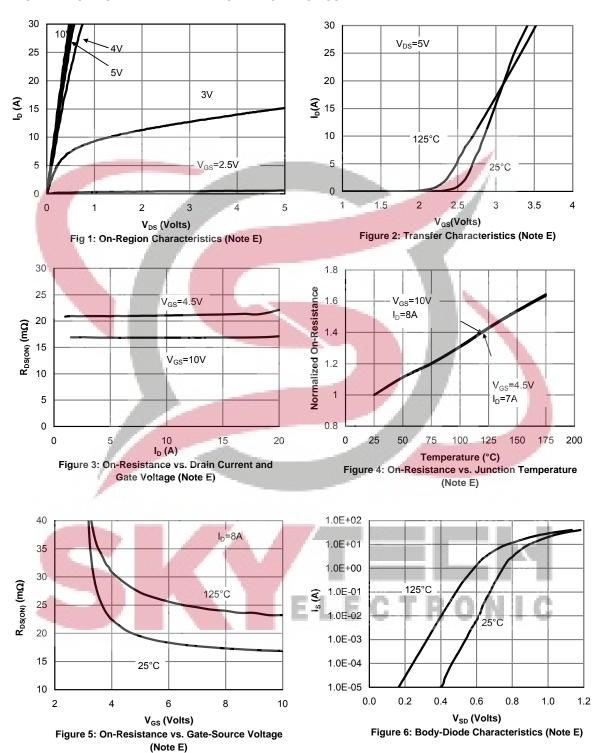
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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150°C. Ratings are based on low frequency and duty cycles to keep initial T_J =25°C.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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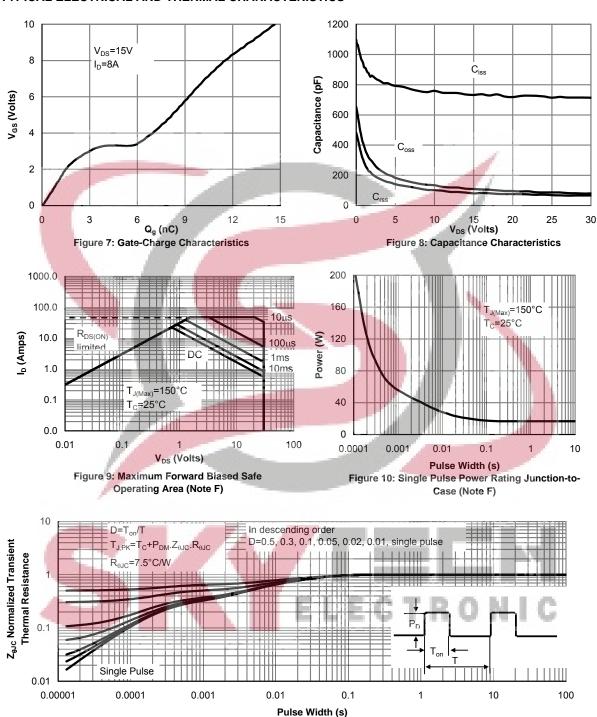


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



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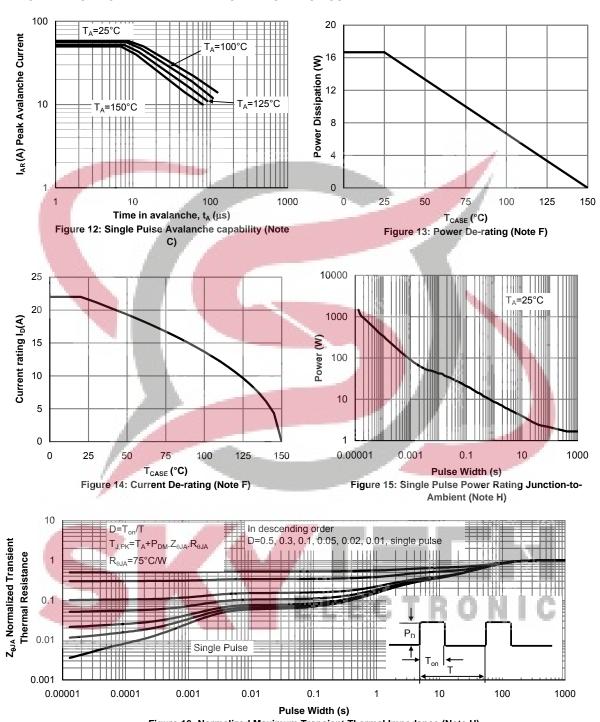


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)



Gate Charge Test Circuit & Waveform

